GALLIUM NITRIDE (GaN) FET ▲ GPT65Z3YMR

GaN POWER TECHNOLOGY

GPT65Z3YMR

650V ▲ 245mΩ ▲ GaN FET

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GALLIUM NITRIDE GaN FET ▲ SMD type Normally off device Easy to drive with standard MOSFET driver Ultra-thin DFN8080 package with 0.9mm height Moisture Sensitivity Level ▲ MSL 3 Ultra-low Q_{RR} and very robust design

SPECIFICATION

Item (T _c = 25°C, unless otherwise noted)		Characteristics
Operating Temperature Range	TJ	-55°C to +150°C
Storage Temperature Range	Ts	-55°C to +150°C
Drain-Source Voltage	V _{DSS}	650V
Transient Drain-Source Voltage Note 1	V _{TR(DSS)}	800V
Drain-Source On-State Resistance Note 2	R _{DS(ON)TYP}	245mΩ
Typical Recovered Charge Note 3	Q _{RR}	40nC
Typical Total Gate Charge	Q _G	22nC

RoHS

REACH

HALOGEN

FREE

Notes

1: Spike duty cycle DC < 0.01, spike duration time < 20µs during off-state mode

2: V_{GS} = 8V, I_D = 4A, T_J = 25°C

3: See diode reverse recovery test circuit and waveform, Fig. 17, and Fig. 18

APPLICATIONS

Battery	Power	LED	Wireless	AC/DC	DC/DC	Class D Audio
Chargers	Adapters	Lighting	Power	Converter	Converter	Amplifiers
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PIN DESCRIPTION

Circuit Diagram	Outline - Bottom View	Pin No.	Symbol	Description
G S	2 1	1 2 3	G D S	Gate Drain Source

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STORAGE AND HANDLING CONDITIONS

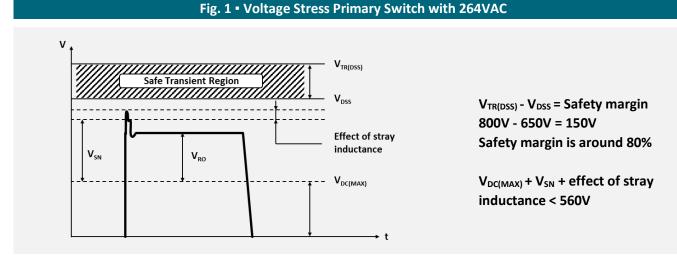
ESD level	Floor life	Conditions	MSL
HBM class 2	168 hours	T _A < 30°C, RH < 60%	3

ABSOLUT MAXIMUM RATINGS A T_c = 25°C, unless otherwise noted

ltem	Condition	Symbol	Limit	Unit
Drain-Source Breakdown Voltage		V _{DSS}	650	V
Transient Drain-Source Voltage Note1		V _{(TR)DSS}	800	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current	T _C = 25°C ^{Note 2}	I _D	9	А
Continuous Drain Current	T _C = 100°C ^{Note 2}	ID	6	А
Pulse Drain Current	T_c = 25°C, Pulse Width = 10µs	I _{DM}	31	А
Maximum Power Dissipation	T _C = 25°C	P _D	38	W
Operating Temperature Range	Case	Tc	-55 to +150	°C
Operating Temperature Range	Junction	TJ	-55 to +150	°C
Storage Temperature Range		Ts	-55 to +150	°C

Note:

- 1: Spike duty cycle DC < 0.01, spike duration time < 20µs during off-state mode
- 2: See application information for increased stability at high current operation, fig. 2



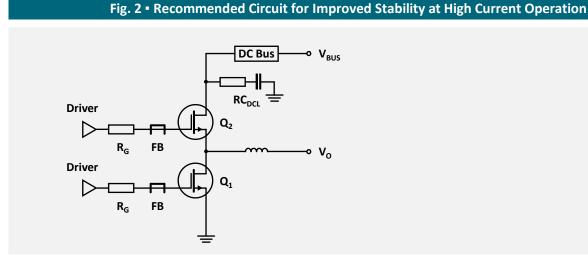
Maximum input voltage V_{DC(MAX)} V_{RO} Reflected output voltage Snubber capacitor voltage V_{SN}

- Drain-Source breakdown voltage
- V_{DSS}
- Transient Drain-source voltage V_{(TR)DSS}

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APPLICATION INFORMATION



A ferrite bead (FB) should be connected in series with the gate pin to dampen the resonant circuit of gate-source loop inductance and the input capacitance of the GaN-FET. The ferrite bead should be placed as close as possible to the gate pin to minimize the gate-source loop. (See figure 2). This causes fast switching stability. We recommend an impedance of 470Ω at 100MHz for the ferrite bead. In addition, a series resistance (R_G) of 33Ω should be provided.

Furthermore, a DC-link snubber should always be used to eliminate instability of the GaN-FET. In the simplest case, an RC combination is connected in parallel to the DC link bus, which significantly reduces the Q factor of any resonance in the bus. We recommend an MLCC with 68pF and an SMD resistor with 15Ω as well-suited values.

THERMAL CHARACTERISTIC RATINGS

Items		Тур.
Thermal Resistance Junction to Ambient Note 1	R _{thJA}	50°C/W
Thermal Resistance Junction to Case	RthJC	3.3°C/W

Note:

1: Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm² copper and 70μm thickness

ELECTRICAL CHARACTERISTICS A T_C = 25°C, unless otherwise noted

Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	V _{GS} = 0V	V _{DSS}	650			V
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 500 \mu A$	V_{GSth}	1	1.6	2.5	V
Gate-Source Leakage Current	V_{GS} = 20V, V_{DS} = 0V	I _{GSS}			150	nA
Gate-Source Leakage Current	V_{GS} = -20V, V_{DS} = 0V	I _{GSS}			-150	nA
Drain-Source Leakage Current	$V_{DS} = 650V, V_{GS} = 0V$	I _{DSS}		10	20	μA
Drain-Source Leakage Current	V_{DS} = 650V, V_{GS} = 0V, T_{J} = 150°C	I _{DSS}		50		μA
Drain-Source On-State Resistance	$V_{GS} = 8V$, $I_D = 4A$	R _{DS(ON)}		245	300	mΩ
Drain-Source On-State Resistance	V _{GS} = 8V, I _D = 4A, T _J = 150°C	R _{DS(ON)}		500		mΩ
Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Dynamic Characteristics						
Input Capacitance	V_{DS} = 650V, V_{GS} = 0V, f = 1MHz	CISS		500		pF
Output Capacitance	V_{DS} = 650V, V_{GS} = 0V, f = 1MHz	Coss		20		pF
Reverse Transfer Capacitance	$V_{DS} = 650V, V_{GS} = 0V, f = 1MHz$	C _{RSS}		2		рF
Effective Output Capacitance, Energy Related ^{Note 1}	$V_{DS} = 0$ to 650V, $V_{GS} = 0V$	C _{O(ER)}		25		pF
Effective Output Capacitance, Time Related Note 2	$V_{DS} = 0$ to 650V, $V_{GS} = 0V$	C _{O(TR)}		45		pF
Total Gate Charge	V_{DS} = 400V, V_{GS} = 0 to 12V, I_D = 5.5A	Q _G		22		nC
Gate-Source Charge	V_{DS} = 400V, V_{GS} = 0 to 12V, I_{D} = 5.5A	Q _{GS}		3		nC
Gate-Drain Charge	V_{DS} = 400V, V_{GS} = 0 to 12V, I_D = 5.5A	Q_{GD}		3.5		nC
Output Charge	V _{DS} = 0 to 650V, V _{GS} = 0V	Q _{OSS}		32		nC
Turn-On Delay	$V_{DS} = 400V, V_{GS} = 0 \text{ to } 12V, I_D = 3A,$ $R_G = 30\Omega$	t _{D(ON)}		20		ns
Rise Time	$V_{DS} = 400V, V_{GS} = 0 \text{ to } 12V, I_D = 3A, \\ R_G = 30\Omega$	t _R		7		ns
Turn-Off Delay	$V_{DS} = 400V, V_{GS} = 0 \text{ to } 12V, I_D = 3A, \\ R_G = 30\Omega$	t _{D(OFF)}		80		ns
Fall Time	$V_{DS} = 400V, V_{GS} = 0 \text{ to } 12V, I_D = 3A, \\ R_G = 30\Omega$	t _F		6		ns
ltem	Condition	Symbol	Min.	Тур.	Max.	Unit
Source-Drain Diode						
	$I_{S} = 2A, V_{GS} = 0V$			1		V
Source-Drain Voltage	I _S = 5A, V _{GS} = 0V	V_{SD}		1.5		V
Reverse Recovery Time Note 3	$I_{S} = 3A, V_{GS} = 0V, V_{DS} = 400V,$ di/dt = 1000A/µs	t _{RR}		12		ns
Recovered Charge Note 4	$I_{s} = 3A, V_{Gs} = 0V, V_{Ds} = 400V,$	Q _{RR}		40		nC

Notes:

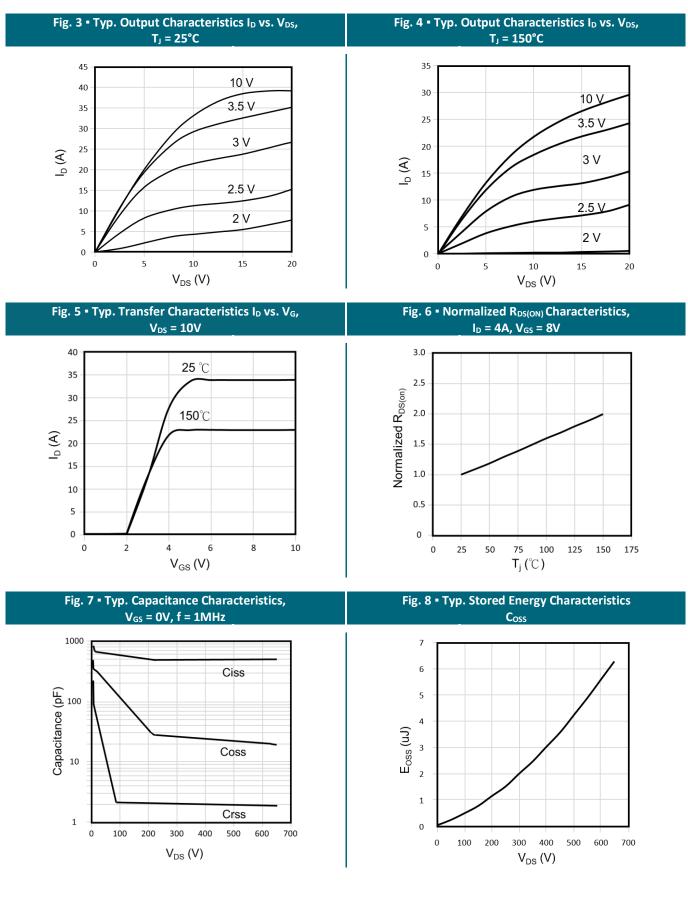
- Equivalent capacitance to give same stored energy from 0V to the stated $V_{\mbox{\scriptsize DS}}$ 1:
- 2: Equivalent capacitance to give same charging time from 0V to the stated V_{DS}
- 3: See diode reverse recovery test circuit and waveform, fig. 17 and fig 18
- 4: See diode reverse recovery test circuit and waveform, fig 17 and fig. 18

 $di/dt = 1000A/\mu s$



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REFERENCE DATA

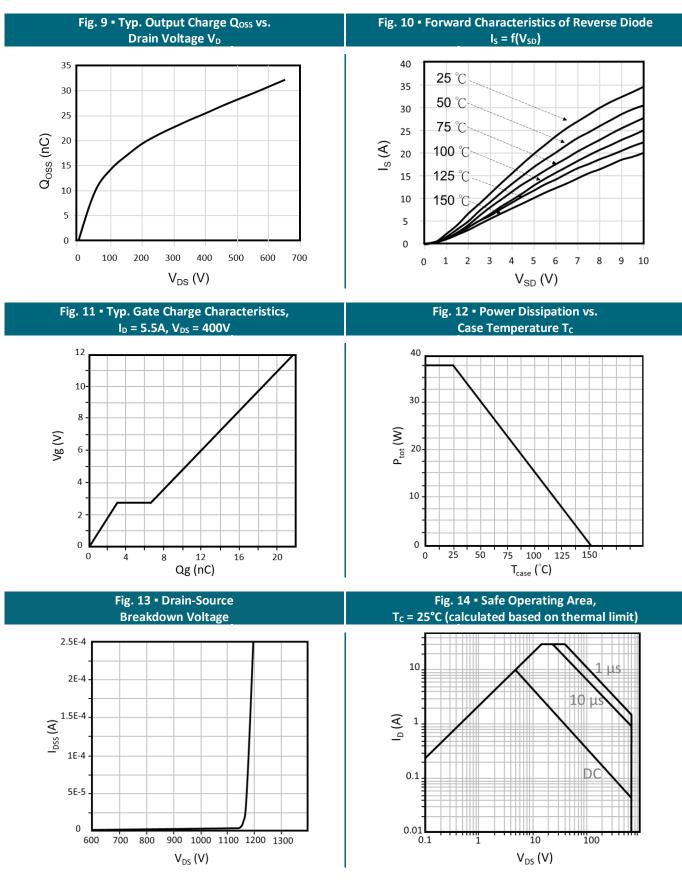


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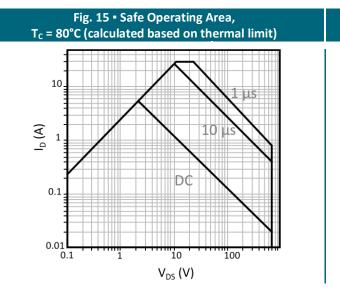
REFERENCE DATA

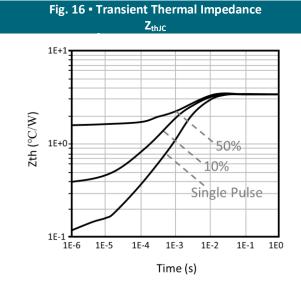


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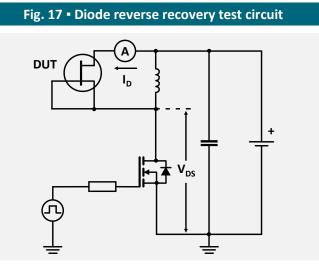
REFERENCE DATA







TEST CIRCUITS AND WAVEFORMS



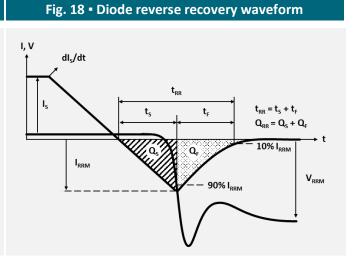


Fig. 19 • Switching time test circuit

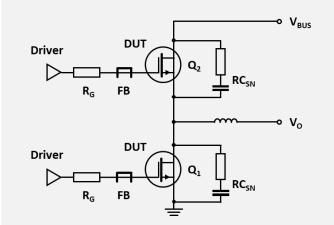


Fig. 21 • Dynamic R_{DS(ON)eff} test circuit

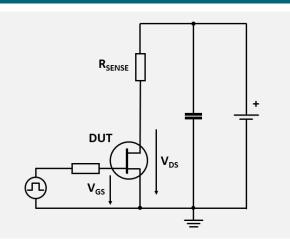


Fig. 20 - Switching time waveform

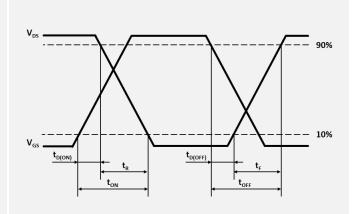
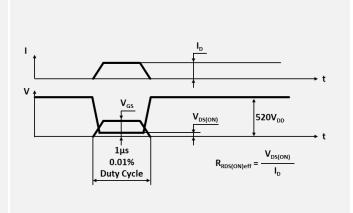


Fig. 22 • Dynamic R_{DS(ON)eff} waveform



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LAYOUT GUIDELINES

The layout of GaN FETs is very important for performance and EMI due to the GaN FETs are normally operated under high voltage and high current. Figure 24 and Figure 25 show an example of a good power layout loop:

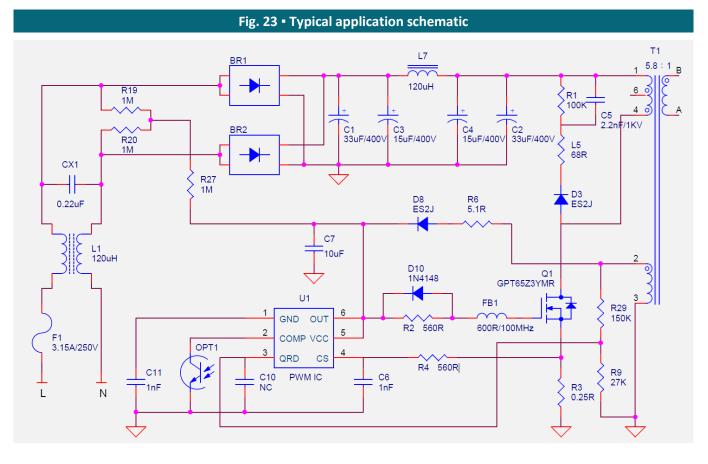


Fig. 24 • Top layer for FR4 1.6mm

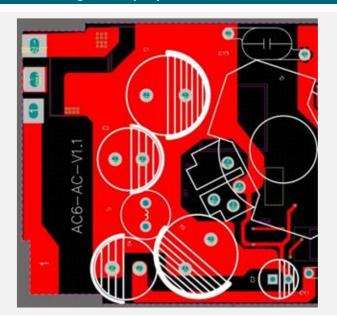
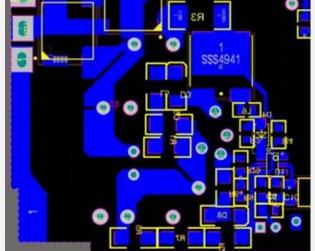




Fig. 25 • Bottom layer for FR4 1.6mm





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POWER-LOOP INDUCTANCE

The GaN FET has operated at a high transient current (di/dt) state. Therefore, the ringing, EMI, and voltage stress on GaN FET could be reduced by minimizing the inductance of the loop.

- 1. GND with a large area copper plane provides a low inductance ground for the GaN FET (Q1).
- 2. The power device GaN FET (Q1), diode (D3), and transformer (T1) are placed as close as possible to reduce the inductance.
- 3. The power device GaN FET (Q1) and resistor (R3) are placed as close as possible to reduce inductance and avoid abnormal switching.
- 4. Resistor (R3) and decoupling capacitor (C1) are placed as close as possible to minimize the current path and reduce the inductance.

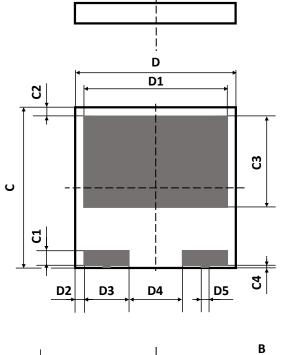
SWITCHING NODE CAPACITANCE

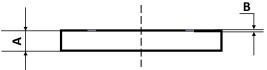
GaN devices have very low switching losses due to its low output capacitance and fast switching with high transient voltage (dv/dt). Therefore, additional capacitance on the output node should be minimized.

- 1. Shrinking the area of copper reduces the extra capacitance of the switching node.
- 2. Switching Node Trace should not overlap with Power plane and GND plane.
- 3. The copper plane of the Switching Node is not used for heat dissipation of the circuit board.



PACKAGE OUTLINE AND PART MARKING



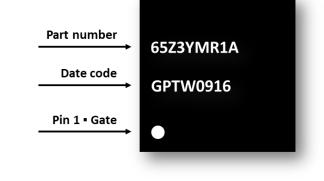


Sym	Millimeters
А	0.900 ± 0.050
В	0.203 ± 0.008
С	8.000 ± 0.050
C1	0.800 ± 0.025
C2	0.400 ± 0.025
C3	4.600 ± 0.050
C4	0.100 ± 0.025

DATE CODE

Example:	0916
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09		1	6
Week of the Month		Year	
		16	2022
01	1 st	17	2023
02	2 nd	18	2024
03	3 rd	19	2025
04	4 th	1A	2026
		1B	2026
52	52 nd		
		1F	2031



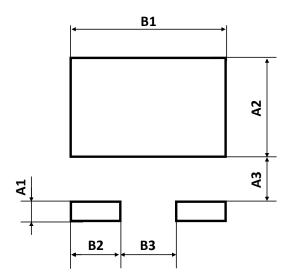
Date code:		
09:	e.g., week 09	
16:	e.g., 2022	

Sym	Millimeters
D	8.000 ± 0.050
D1	7.200 ± 0.050
D2	0.400 ± 0.025
D3	2.300 ± 0.025
D4	2.600 ± 0.025
D5	0.400 ± 0.025

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RECOMMENDED PAD LAYOUT FOR DFN 8080



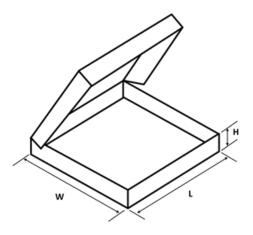
Sym	Millimeters
A1	1.000
A2	4.750
A3	2.000
B1	7.350
B2	2.450
B3	2.450

ORDERING INFORMATION

Part Number	Package	Packing	Quantity	Reel Diameter
GPT65Z3YMR	Thin DFN8080	Tape and Reel	2 500pcs	330mm (13")

REEL BOX DIMENSION All dimensions in mm

Outside Dimensions				
Ø 330mm reel				
W 350				
L	350			
Н	80			





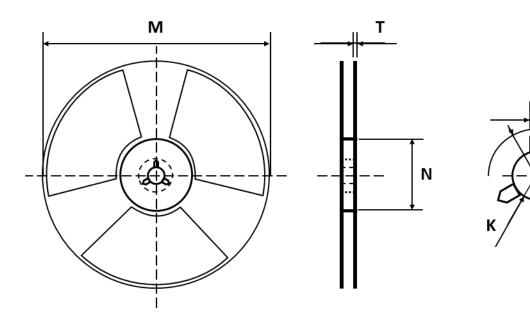
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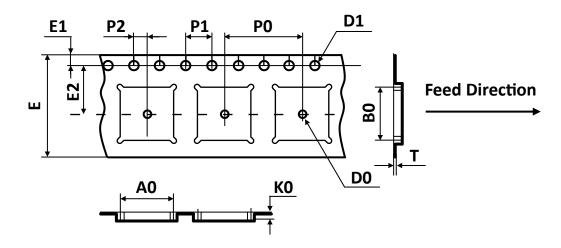
GaN POWER TECHNOLOGY

REEL DIMENSIONS All dimensions in mm



Tape Size	Reel Size	М	N	т	Н	К	S
		Ø330.00	Ø102.00	2.00	13.00	10.50	2.00
24mm	Ø330	±0.20	±0.10	±2.0	+0.50 -0.20	±0.25	±0.25

TAPE DIMENSIONS All dimensions in mm



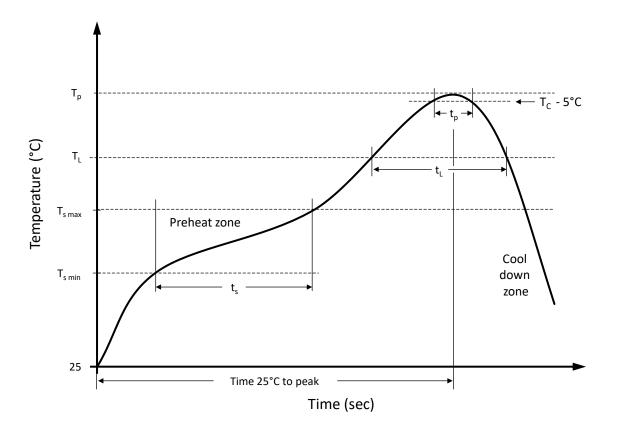
Package	A0	B0	К0	D0	D1	E	E1	E2	P0	P1	P2	т
DFN8080	8.30	8.30	1.15	1.50	1.50	24.00	1.75	7.50	12.00	4.00	2.00	0.30
DFINOUOU	±0.10	±0.10	±0.10	±0.10	±0.10	±0.30	±0.10	±0.10	±0.10	±0.10	±0.10	±0.05



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RECOMMENDED REFLOW SOLDERING PROFILE



Recommended reflow soldering conditions ▲ **Refer to JEDEC J-STD-020E**

Profile Features		Sn-Pb Eutetic Assembly	Pb-Free Assembly
Preheat temperature min.	$T_{s min}$	100 °C	150 °C
Preheat temperature max.	$T_{s max}$	150 °C	200 °C
Preheat time t_s from $T_{s min}$ to $T_{s max}$	ts	120 seconds	120 seconds
Ramp-up rate (T₁ to Tp)		max. 3 °C/second	max. 3 °C/second
Liquidous temperature	TL	183 °C	217 °C
Time t_L maintained above T_L	tL	150 seconds max.	150 seconds max.
Peak package body temperature	Tp	235°C	260°C
Timeframe of within 5°C below and up to max actual peak body temperature	t _p	20 seconds max.	30 seconds max.
Ramp-down rate $(T_L to T_p)$		max. 6 °C/second	max. 6 °C/second
Time 25°C to peak temperature		max. 6 minutes	max. 8 minutes

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REVISION TABLE

Revision	Date	Status	Notes
001	11/11/2022	Initial release	Initial publication

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